# INTERNATIONAL RECTIFIER IOR

# 2N681 & 2N5204 SERIES 25 and 35 Amp RMS SCRs

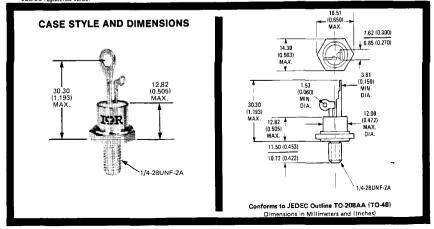
#### Major Ratings and Characteristics

-	2N6B1-92	2N5204-07	Units
T(RMS)	25	35	Α
IT(AV)	16*	22*	Α
® T <sub>C</sub>	-65 to 65*	-40 to 40	°C
TSM			
@ 50 Hz	145	285	
@ 60 Hz	150*	300*	Ĺ ^
12t			
@ 50 Hz	103	410	A <sup>2</sup> s
@ 60 Hz	94	375	] A-s
<sup>I</sup> GT	40	40	mA
dv/dt	-	100*	V/μs
di/dt	75-100	100	A/μs
Tj	-65 to 125*	-40 to 125*	°C
VRRM, VDRM range	25-800	600-1200	V

#### **Description/Features**

- General purpose stud mounted
- Broad forward and reverse voltage range — through 1200 volts
- Can be supplied to meet stringent military, aerospace and other highreliability requirements

\*JEDEC registered value.





## VOLTAGE RATINGS (Applied gate voltage zero or negative)

	VRRM- VDRM — Max. Repetitiva Peak Reverse and Off-State Voltage (V)	VRSM Max. Non Repetitive Peak Reverse Voltage tp < 5 ms (V)		
Part Numbers	T <sub>J</sub> = -65°C to 125°C	T <sub>J</sub> = -65°C to 125°C		
2N681	25*	35°		
2N682	50*	75*		
2N683	100*	150*		
2N685	200*	300*		
2N687	300*	400*		
2N688	400*	500°		
2N689	500*	600*		
2N690	600*	720*		
2N691	700*	840*		
2N692	800*	960*		
	T <sub>J</sub> = -40°C to 125°C	T <sub>J</sub> = -40°C to 125°C		
2N5204	600	720		
2N5205	800	960		
2N5206	1000	1200		
2N5207	1200	1440		

#### **ELECTRICAL SPECIFICATIONS**

		2N681-92	2N5204-07	Units	Conditions	
	ON-STATE					
T(RMS)	Max. RMS on-state current	25	35	Α		
ITIAV)	Max. average on-state current	16*	22*	A	180° half sine wave conduction	
	@ T <sub>C</sub> =	-65 to 65*	-40 to 40*	°C	160° nait sine wave conduction	
ITSM	Max. peak one cycle, non- repetitive surge current	145	285	A	50 Hz half cycle sine wave Following any rated or 6 ms rectangular pulse load condition, and	
		150*	300*		60 Hz half cycle sine wave or 5 ms rectangular pulse plied following surge.	
		170	340	Ŷ.	50 Hz half cycle sine wave or 6 ms rectangular pulse above except with	
		180	355		60 Hz half cycle sine wave or 5 ms rectangular pulse ing surge = 0.	
1 <sup>2</sup> t	Max. I <sup>2</sup> t capability, for fusing	103	410	A <sup>2</sup> s	t = 10 ms Rated V <sub>RRM</sub> applied following surge	
		94	375		t = 8.3 ms initial T <sub>J</sub> = 125°C	
12,	Max, 12t capability, for individual device fusing	145	580	A <sup>2</sup> s	t = 10 ms V <sub>RRM</sub> = 0 following surge,	
		135	530		t = 8.3 ms initial T <sub>J</sub> = 125°C.	
l <sup>2</sup> √t	Max. 12 \( \square\) t capability, for individual device fusing ()	1450	5800	$A^2\sqrt{s}$	t = 0.1 to 10ms initial $T_J \le 125^{\circ}C$ $V_{RRM}$ following surge = 0.	
V <sub>TM</sub>	Max. peak on-state voltage	2*	2.3*	٧	T <sub>J</sub> = 25°C, I <sub>T(AV)</sub> = 16A (50A peak) 2N681, I <sub>T(AV)</sub> = 22A (70A peak) 2N5204	
1 <sub>H</sub>	Mex, holding current	20 @ 25°C†	200* @ -40°C	mA	Anode supply = 24V, initial 17 = 1.0A.	
	BLOCKING					
dv/dt	Min. critical rate-of-rise of off-state voltage	100 <sup>†</sup>	100*	Vlμs	T <sub>J</sub> = 125°C. Exponential to 100% rated V <sub>DRM</sub>	
		250 <sup>†</sup>	250		T <sub>J</sub> = 125°C. Exponential to 67% rated V <sub>DRM</sub>	

<sup>†</sup> Typical



### **ELECTRICAL SPECIFICATIONS (Continued)**

		2N681-92	2N5204-07	Units	Conditions
	BLOCKING (Continued)				
I <sub>D(-)</sub>	Max. reverse and off-state current  VRRM & VDRM = 5V	IR(AV) & ID(AV) (Average Values)	IRM & IDM (Peak Values)		
	25 to 150V	6.5*	_	1	
	200 & 250V	6.0*			
	300V	5.0*			
	400V	4.0*		mΑ	T <sub>f</sub> = 125°C, gate open circuited.
	500V	3.0*	-		
	600V	2.5*	3.3*		
	700V	2.25*	-	ĺ	
	800V	2.0*	2.5*	1	
	1000V		2.0*	İ	
	1200V		1.7*		
	SWITCHING				·
<sup>t</sup> d	Typical delay time	1	1	μς	$\begin{split} &T_C \approx 25^{\text{O}}\text{C}, V_{DM} = \text{rated } V_{DRM}, I_{TM} = 10\text{A dc} \\ &\textit{resistive circuit. Gate pulse: } &10V, 40\Omega \textit{ source,} \\ &t_p = 6 \textit{ \mus, t}_r = 0.1 \textit{ \mus.} \end{split}$
di/dt	Max, non-repetitive rate of rise of turned-on current  VDM = 25 to 600V	100			$T_C$ = 125°C, $V_{DM}$ = rated $V_{DRM}$ , $t_{TM}$ = 2 x di/dt, Gate pulse: 20V, $15\Omega$ , $t_p$ = 6 $\mu$ s, $t_r$ = 0.1 $\mu$ s max. Per JEDEC standard RS-397, 5.2.2.6.
	= 700 to 800V	75	-	A/µs	
		-	100		$T_C$ = 125°C, $V_{DM}$ = 600V, $I_{TM}$ = 200A @ 400 Hz, max., Gate pulse: 20V, 15Ω, $t_p$ = 6 μs, $t_r$ = 0.1 μs max. Per JEDEC standard RS-397, 5.2.2.6.
	TRIGGERING				
PGM	Max, peak gate power	5*	60*	w	$t_p \le 5$ ms for 2N681 series; $t_p \le 500$ µs for 2N5204 series.
PG(AV)	Max, average gate power	0.5*	0.5*	w	_
<sup>+∤</sup> GM	Max, peak positive gate current	2*	2	Α_	
<sup>+V</sup> GM	Max, peek positive gate voltage	10*		٧	
-VGM	Max. peak negative gate voltage	5*	5*	٧	
<sup>I</sup> GT	Max, required DC gate current to trigger	80*	80*		T <sub>C</sub> = min. rated value. Max, required gate trigger current is the lowest value which will trigger all units with +6V anode-to-cathode.
		40	40	_ •	T <sub>C</sub> = 25°C
		18.5	20	mΑ	T <sub>C</sub> = 125°C
	Typical DC gate current to trigger	30	30		T <sub>C</sub> ≈ 25°C +6V anode-to-cathode
V <sub>GT</sub>	Max, required DC gate voltage to trigger	3*	3*		$T_C \simeq -65^{\circ}C$ , Max. required gate trigger voltage is the lowest value which will trigger all units with $+6V$ anode-to-cathode.
		2	2	٧	T <sub>C</sub> = 25°C
	Typical DC gate voltage to trigger	1.5	1.5		T <sub>C</sub> ≈ 25°C +6V anode-to-cathode
v <sub>GD</sub>	Max, DC gate voltage not to trigger	0.25*	0.25*	٧	$T_C\approx 125^{o}C.$ Max. gate voltage not to trigger is the maximum value which will not trigger any unit with rated $V_{DRM}$ anode-to-cathode.



#### THERMAL-MECHANICAL SPECIFICATIONS

		2N681-92	2N5204-07	Units	Conditions
ТJ	Operating junction temperature range	-65* to 125*	-40° to 125°	°C	
T <sub>stg</sub>	Storage temperature range	-65° to 125°	-40° to 125°	°C	
R <sub>thJC</sub>	Max. internal thermal resistance, junction to case	1.5	1,5*	deg. C/W	DC operation
R <sub>thCS</sub>	Thermal resistance, case to sink	0.35	0.35	deg. C/W	Mounting surface smooth, flat and greased.
	Mounting torque to nut ±10%	20,(27.5)		lbf • in.	
		0.23(.32)		kgf · m	Lubricated threads (non- lubricated threads).
		2,3(3.1)		N-m	1
	to device	25		lbf •in.	
			0.29	kgf · m	Lubricated threads.
		2.8		N·m	]
wt	Approximate weight	14(0.49)	14 (0.5)	g (az.)	
	Case Style TO		A (TO-48)		

<sup>\*</sup>JEDEC Registered value.

#### 2N681 Series

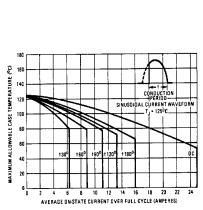


Fig. 1 - Maximum Allowable Case Temperature Vs. Average On-State Current, 2N681 Series

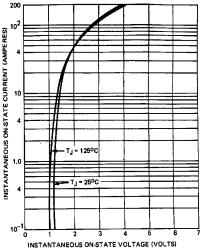


Fig. 2 - Maximum On-State Voltage Vs. Current, 2N681 Series

#### 2N681 Series

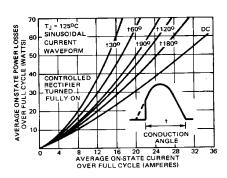


Fig. 3 — Maximum Low Level On-State Power Loss Vs. Current (Sinusoidal Current Waveform), 2N681 Series

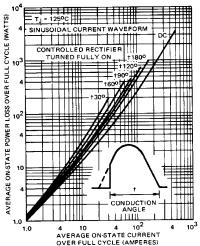


Fig. 4 — Maximum High Level On-State Power Loss Vs. Current (Sinusoidal Current Waveform), 2N681 Series

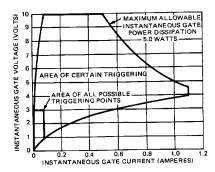


Fig. 5 - Gate Characteristics, 2N681 Series

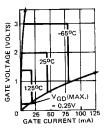


Fig. 5A — Area of All Possible Triggering Points Vs. Temperature 2N681 Series

#### 2N681 Series

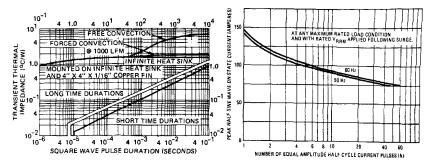


Fig. 6 — Maximum Transient Thermal Impedance, Junction to Case, Vs. Pulse Duration, 2N681 Series

Fig. 7 — Maximum Non-Repetitive Surge Current, Vs. Number of Current Pulses, 2N681 Series

#### 2N5204 Series

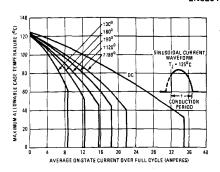


Fig. 8 — Maximum Allowable Case Temperature Vs. Average On-State Current (Sinusoidal Current Waveform), 2N5204 Series

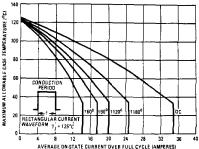


Fig. 9 — Maximum Allowable Case Temperature
Vs. Average On-State Current
(Rectangular Current Waveform), 2N5204 Series

<u>\_i 120°</u> \+ 180° \nc

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#### 2N5204 Series

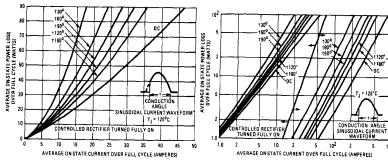


Fig. 10 - Maximum Low-Level On-State Power Loss Vs. Average On-State Current (Sinusoidal Current Waveform), 2N5204 Series

Fig. 11 - Maximum High-Level On-State Power Loss Vs. Average On-State Current (Sinusoidal Current Waveform), 2N5204 Series

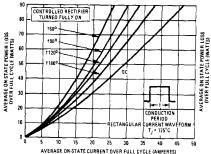


Fig. 12 - Maximum Low-Level On-State Power Loss Vs. Average On-State Current (Rectangular Current Waveform), 2N5204 Series

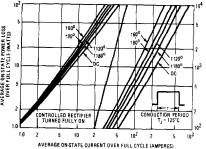


Fig. 13 - Maximum High-Level On-State Power Loss Vs. Average On-State Current (Rectangular Current Waveform), 2N5204 Series

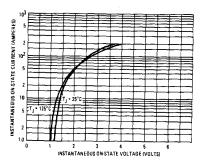


Fig. 14 - Maximum Instantaneous On-State Voltage Vs. Instantaneous On-State Current, 2N5204 Series

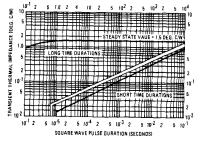


Fig. 15 - Maximum Transient Thermal Resistance, Junction to Case, Vs. Pulse Duration, 2N5204 Series